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### **Power MOSFET**

## 25 V, 98 A, Single N-Channel, DPAK/IPAK

#### **Features**

- Trench Technology
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Devices

#### **Applications**

- VCORE Applications
- DC-DC Converters
- Low Side Switching

### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise stated)

Para	Parameter				
Drain-to-Source Vo	$V_{DSS}$	25	V		
Gate-to-Source Vol	Gate-to-Source Voltage				V
Continuous Drain		$T_A = 25^{\circ}C$	Ι <sub>D</sub>	18	Α
Current R <sub>θJA</sub> (Note 1)		T <sub>A</sub> = 85°C		14	
Power Dissipation R <sub>θJA</sub> (Note 1)		T <sub>A</sub> = 25°C	$P_{D}$	2.24	W
Continuous Drain		T <sub>A</sub> = 25°C	ID	14	Α
Current R <sub>θJA</sub> (Note 2)	Steady State	T <sub>A</sub> = 85°C		10.9	
Power Dissipation $R_{\theta JA}$ (Note 2)	Siale	T <sub>A</sub> = 25°C	P <sub>D</sub>	1.35	W
Continuous Drain	1	T <sub>C</sub> = 25°C	I <sub>D</sub>	98	Α
Current R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 85°C		76	
Power Dissipation $R_{\theta JC}$ (Note 1)		T <sub>C</sub> = 25°C	$P_{D}$	66.7	W
Pulsed Drain Current	t <sub>p</sub> =10μs	T <sub>A</sub> = 25°C	I <sub>DM</sub>	197	Α
Current Limited by P	ackage	T <sub>A</sub> = 25°C	I <sub>DmaxPkg</sub>	45	Α
Operating Junction a Temperature	Operating Junction and Storage Temperature				°C
Source Current (Boo	I <sub>S</sub>	56	Α		
Drain to Source dV/d	dV/dt	6	V/ns		
Single Pulse Drain-to-Source Avalanche Energy ( $T_J$ = 25°C, $V_{DD}$ = 50 V, $V_{GS}$ = 10 V, $I_L$ = 21 $A_{pk}$ , $L$ = 1.0 mH, $R_G$ = 25 $\Omega$ )			EAS	220	mJ
Lead Temperature for (1/8" from case for 1		Purposes	T <sub>L</sub>	260	°C

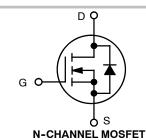
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.



#### ON Semiconductor®

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V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
25 V	4.3 m $\Omega$ @ 10 V	98 A
25 V	6.0 mΩ @ 4.5 V	96 A







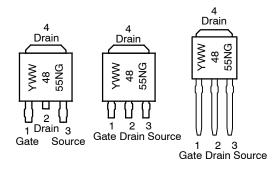


CASE 369AA DPAK (Bent Lead) STYLE 2

CASE 369AC 3 IPAK (Straight Lead)

CASE 369D IPAK (Straight Lead DPAK)

# MARKING DIAGRAMS & PIN ASSIGNMENTS



Y = Year WW = Work Week 4855N = Device Code G = Pb-Free Package

#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

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#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	2.25	°C/W
Junction-to-TAB (Drain)	$R_{\theta JC-TAB}$	3.5	
Junction-to-Ambient – Steady State (Note 1)	$R_{\theta JA}$	67	
Junction-to-Ambient – Steady State (Note 2)	$R_{\theta JA}$	111	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
   Surface-mounted on FR4 board using the minimum recommended pad size.

### **ELECTRICAL CHARACTERISTICS** (T<sub>.1</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•					•	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$		25			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				22		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, T <sub>J</sub> = 25°C				1.0	
		$V_{DS} = 20 \text{ V}$ $T_{J} = 125$	T <sub>J</sub> = 125°C			10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS}$	<sub>S</sub> = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.45		2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				TBD		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V I <sub>D</sub> = 30 A			3.5	4.3	
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		4.6	6.0	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 15 A			80		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				2950		
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 12 V			740		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				400		
Total Gate Charge	Q <sub>G(TOT)</sub>				21.8	32.7	
Threshold Gate Charge	Q <sub>G(TH)</sub>	, , , , , , , , , , , , , , , , , , ,	45.771 00.4		2.4		nC
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} =$	15 V, I <sub>D</sub> = 30 A		7.9		
Gate-to-Drain Charge	$Q_{GD}$				8.6		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 1	5 V, I <sub>D</sub> = 30 A		44		nC
SWITCHING CHARACTERISTICS (Note	4)					•	
Turn-On Delay Time	t <sub>d(ON)</sub>				17.75		
Rise Time	t <sub>r</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 15 V, $I_{D}$ = 15 A, $R_{G}$ = 3.0 $\Omega$			31.48		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>				20.28		
Fall Time	t <sub>f</sub>	1			10.74		1
Turn-On Delay Time	t <sub>d(ON)</sub>				10.01		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 11.5 V, V <sub>DS</sub> = 15 V,			16.52		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	I <sub>D</sub> = 15 A, R <sub>G</sub>			32.02		ns
Fall Time	t <sub>f</sub>	1 1			4.35		1

- 3. Pulse Test: pulse width  $\leq$  300  $\mu\text{s},$  duty cycle  $\leq$  2%.
- 4. Switching characteristics are independent of operating junction temperatures.

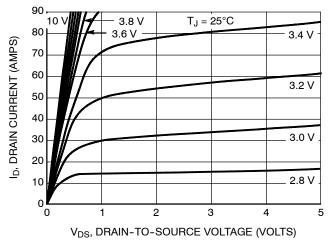
### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACT	ERISTICS			•	•	•	•
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		0.86	1.2	\/
		$V_{GS} = 0 V,$ $I_{S} = 30 A$	T <sub>J</sub> = 125°C		0.74		V
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/μs, I <sub>S</sub> = 30 A			25.5		ns
Charge Time	t <sub>a</sub>				12.9		
Discharge Time	t <sub>b</sub>				12.6		
Reverse Recovery Charge	$Q_{RR}$				13.8		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>				2.49		nH
Drain Inductance, DPAK	L <sub>D</sub>	T <sub>A</sub> = 25°C			0.0164		
Drain Inductance, IPAK	L <sub>D</sub>				1.88		
Gate Inductance	L <sub>G</sub>				3.46		
Gate Resistance	R <sub>G</sub>				0.8		Ω

<sup>3.</sup> Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%. 4. Switching characteristics are independent of operating junction temperatures.

#### TYPICAL PERFORMANCE CURVES

140

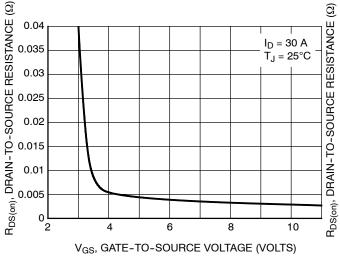


130  $V_{DS} \ge 10 \text{ V}$ T<sub>J</sub> = 125°C Ĉ  $T_J = 25^{\circ}C$ 20 10  $T_J = -55^{\circ}C$ 0 2 3

Figure 1. On-Region Characteristics

V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (VOLTS) Figure 2. Transfer Characteristics





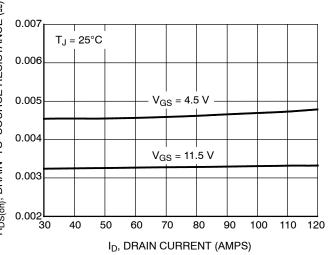
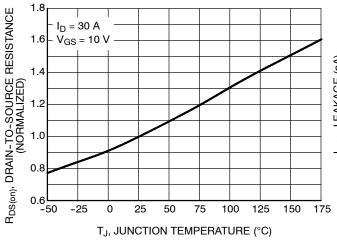


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and **Gate Voltage** 



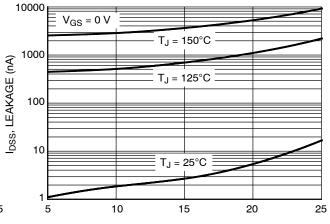


Figure 5. On-Resistance Variation with **Temperature** 

V<sub>DS</sub>, DRAIN-TO-SOURCE VOLTAGE (VOLTS) Figure 6. Drain-to-Source Leakage Current vs. Drain Voltage

#### **TYPICAL PERFORMANCE CURVES**

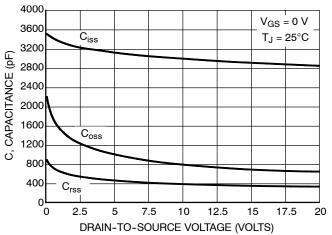


Figure 7. Capacitance Variation

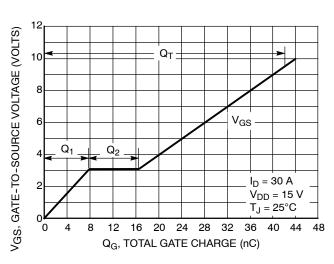


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

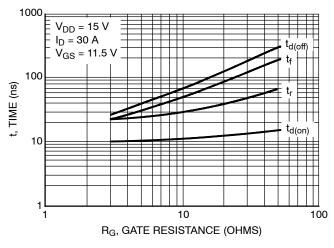


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

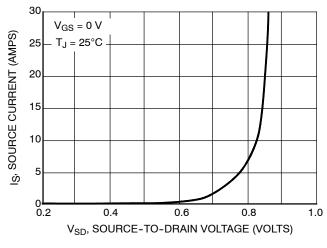


Figure 10. Diode Forward Voltage vs. Current

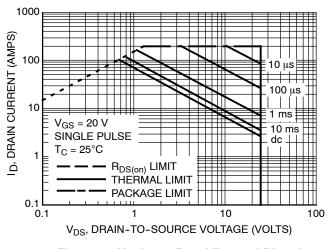


Figure 11. Maximum Rated Forward Biased Safe Operating Area

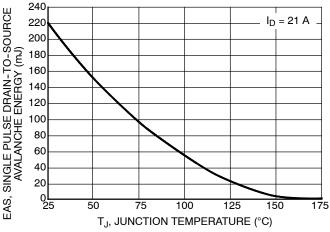


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

#### **ORDERING INFORMATION**

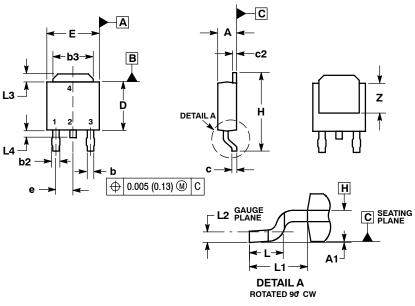
Device	Package	Shipping <sup>†</sup>
NTD4855NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NTD4855NT4H	DPAK (Pb-Free, Halide-Free)	2500 / Tape & Reel
NTD4855N-1G	IPAK (Pb-Free)	75 Units / Rail
NTD4855N-35G	IPAK Trimmed Lead (3.5 $\pm$ 0.15 mm) (Pb-Free)	75 Units / Rail

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### **PACKAGE DIMENSIONS**

#### **DPAK (SINGLE GUAGE)**

CASE 369AA-01 ISSUE B



#### NOTES:

- NOTES:

  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

  2. CONTROLLING DIMENSION: INCHES.

  3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.

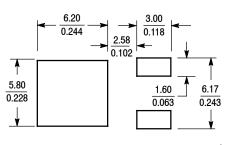
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.

  5. DIMENSIONS D AND F ARE DETERMINED AT THE
- 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INC	HES	MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
C	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
Е	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29	BSC
Н	0.370	0.410	9.40	10.41
٦	0.055	0.070	1.40	1.78
L1	0.108	REF	2.74 REF	
L2	0.020	BSC	0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

#### **SOLDERING FOOTPRINT\***



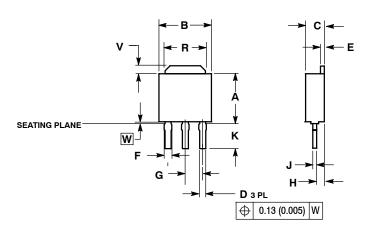
(mm inches) SCALE 3:1

<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS

#### 3 IPAK, STRAIGHT LEAD

CASE 369AC-01 **ISSUE O** 



#### NOTES:

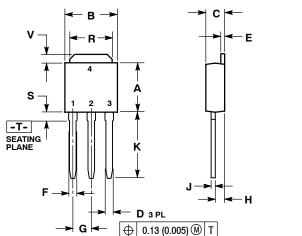
- 1.. DIMENSIONING AND TOLERANCING
- PER ANSI Y14.5M, 1982.

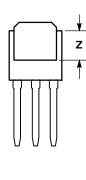
  CONTROLLING DIMENSION: INCH.
- SEATING PLANE IS ON TOP OF DAMBAR POSITION.
- DIMENSION A DOES NOT INCLUDE DAMBAR POSITION OR MOLD GATE.

	INCHES		MILLIM	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.043	0.94	1.09
G	0.090	BSC	2.29 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.134	0.142	3.40	3.60
R	0.180	0.215	4.57	5.46
٧	0.035	0.050	0.89	1.27
W	0.000	0.010	0.000	0.25

#### **IPAK (STRAIGHT LEAD DPAK)**

CASE 369D-01 **ISSUE B** 





- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	2.29	BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2:

PIN 1. GATE

- 2. DRAIN
- SOURCE 3.
- DRAIN

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